

Notice of References Cited	Application/Control No. 09/929,323	Applicant(s)/Patent Under Reexamination CHONG ET AL	
	Examiner Hable Mered	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,836,505	10-2003	Wang et al.	370/352
	B	US-2002/0004935	01-2002	Huotari et al.	717/11
	C	US-2001/0019559	09-2001	Handler et al.	370/468
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/929,323	Applicant(s)/Patent Under Reexamination CHONG ET AL.	
	Examiner Habte Mered	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,636,505	10-2003	Wang et al.	370/352
*	B	US-2002/0004935	01-2002	Huotari et al.	717/11
*	C	US-2001/0018559	09-2001	Handler et al.	370/468
*	D	US-6,667,971	12-2003	Modarressi et al.	370/352
*	E	US-6,182,136	01-2001	Ramanathan et al.	709/224
*	F	US-6,115,755	09-2000	Krishan, Baldev	709/250
*	G	US-6,112,305	08-2000	Dancs et al.	713/156
*	H	US-6,023,464	02-2000	Woundy, Richard	370/352
*	I	US-6,603,758	08-2003	Schmuelling et al.	370/352
*	J	US-2001/0049720	12-2001	Eyer, Mark	709/203
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/929,323	Applicant(s)/Patent Under Reexamination CHONG ET AL.	
	Examiner Habte Mered	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,636,505	10-2003	Wang et al.	370/352
*	B	US-2002/0004935	01-2002	Huotari et al.	717/11
*	C	US-2001/0019559	09-2001	Handler et al.	370/468
*	D	US-6,667,971	12-2003	Modarressi et al.	370/352
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.